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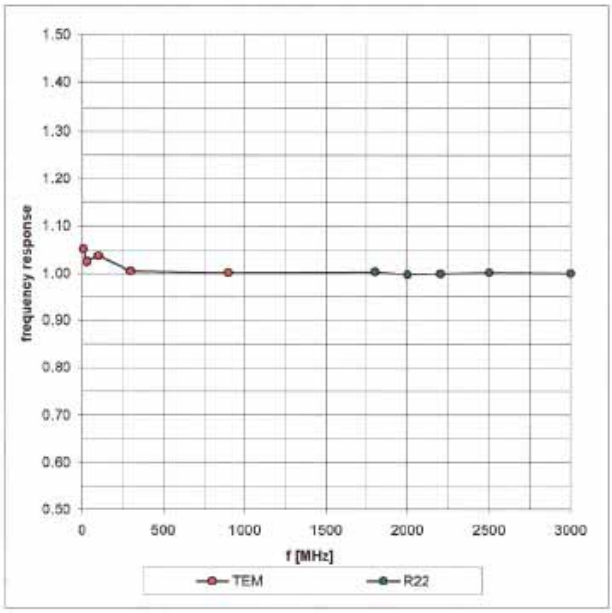
Frequency Response of E-Field

(TEM-Cell:ifi110, Waveguide R22)



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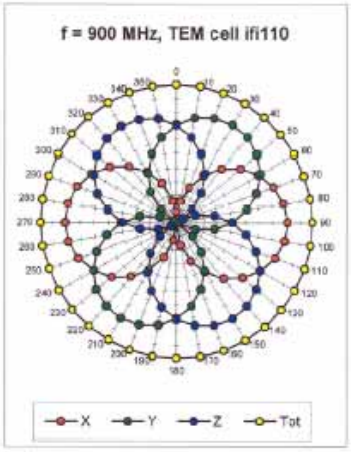
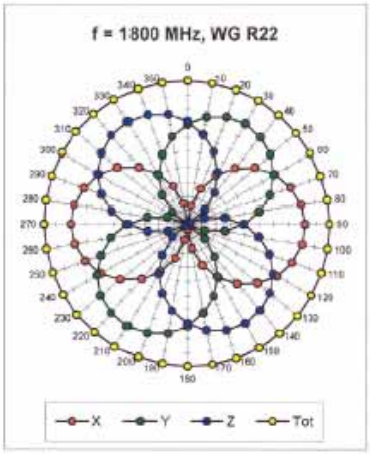
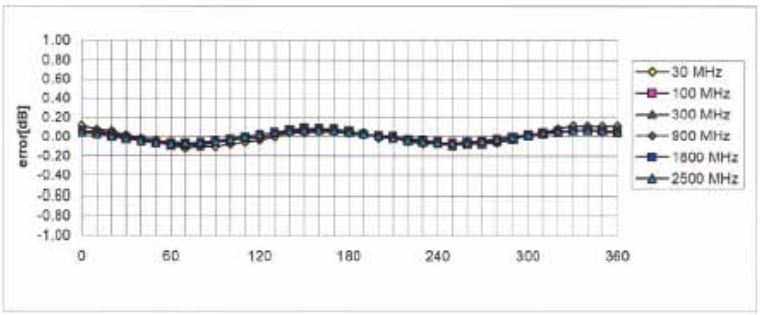
Receiving Pattern (ϕ) , θ = 0°







Axial Isotropy Error < ± 0.2 dB

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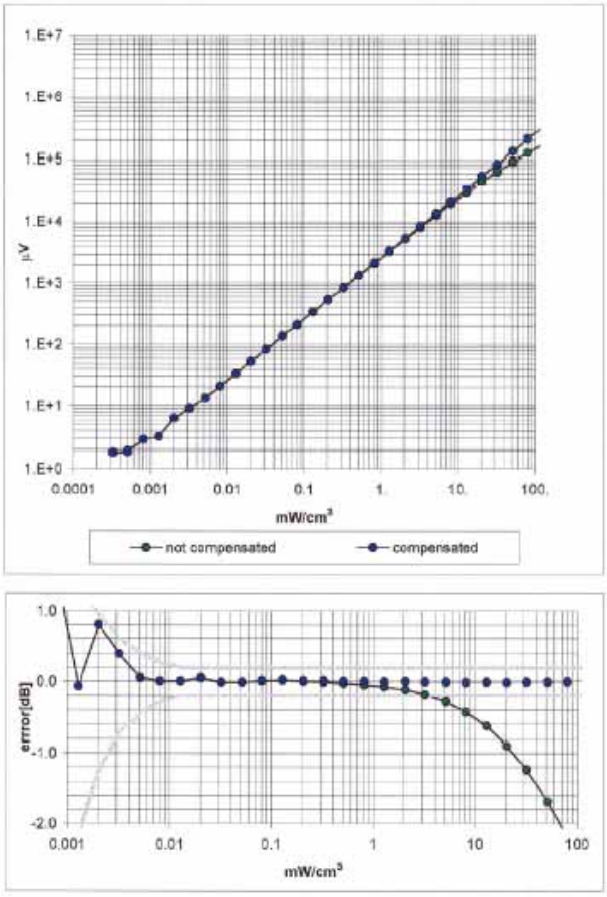
Dynamic Range f(SAR_{head})

(Waveguide R22)



Probe Linearity < ± 0.2 dB

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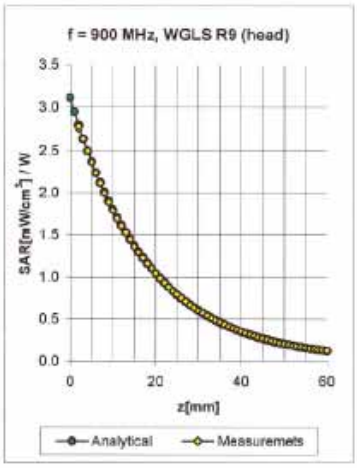
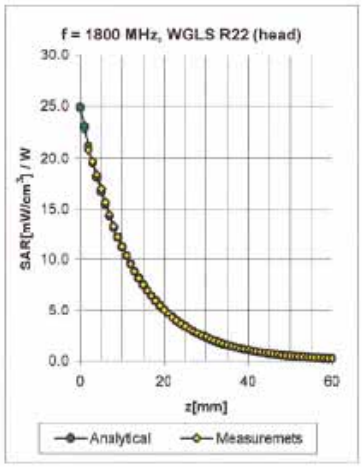
Conversion Factor Assessment





f [MHz]	Validity [MHz][B]	Tissue	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
900	800-1000	Head	41.5 ± 5%	0.97 ± 5%	0.45	0.80	9.59 ± 11.3% (k=2)
1800	1710-1910	Head	40.0 ± 5%	1.40 ± 5%	0.39	1.10	8.30 ± 11.7% (k=2)
5200	4940-5460	Head	36.0 ± 5%	4.66 ± 5%	0.42	1.80	4.88 ± 21.8% (k=2)
5800	5510-6090	Head	35.3 ± 5%	5.27 ± 5%	0.42	1.80	4.38 ± 23.4% (k=2)
5200	4940-5460	Body	49.0 ± 5%	5.30 ± 5%	0.45	1.90	4.14 ± 21.8% (k=2)
5800	5510-6090	Body	48.2 ± 5%	6.00 ± 5%	0.43	1.90	3.85 ± 23.4% (k=2)

[B] The total standard uncertainty is calculated as root-sum-square of standard uncertainty of the Conversion Factor at calibration frequency and the standard uncertainty for the indicated frequency band.

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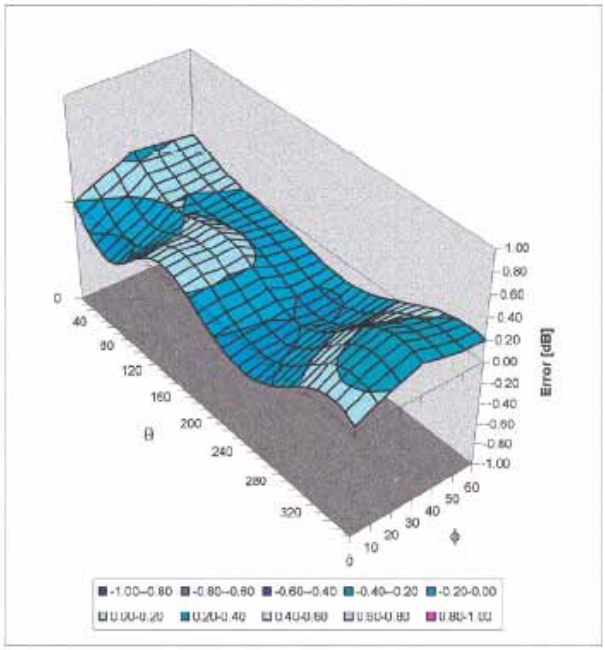
Deviation from Isotropy in HSL

Error (θ,ϕ), f = 900 MHz



Spherical Isotropy Error < ± 0.4 dB

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The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client **Sporton (Auden)**

Certificate No: DAE3-577_Nov04

CALIBRATION CERTIFICATE

Object	DAE3 - SD 000 D03 AA - SN: 577
Calibration procedure(s)	QA CAL-06.v10 Calibration procedure for the data acquisition unit (DAE)
Calibration date:	November 17, 2004
Condition of the calibrated item	In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	7-Sep-04 (Sintrel, No.E-040073)	Sep-05
Secondary Standards	**ID #**	**Check Date (in house)**	**Scheduled Check**
Calibrator Box V1.1	SE UMS 006 AB 1002	16-Jul-04 (SPEAG, in house check)	In house check Jul-05

	Name	Function	Signature
Calibrated by:	Eric Hainfeld	Technician	
Approved by:	Fin Bomholt	R&D Director	i.V.

Issued: November 17, 2004

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Calibration Laboratory of
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Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

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Accreditation No.: SCS 108

Glossary

DAE	digital acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle*: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters contain technical information as a result from the performance test and require no uncertainty.
- *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
- *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
- *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
- *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
- *Input Offset Measurement*: Output voltage and statistical results over a large number of zero voltage measurements.
- *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
- *Input resistance:* DAE input resistance at the connector, during internal auto-zeroing and during measurement.
- *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
- *Power consumption:* Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range:	1LSB =	6.1μV ,	full range =	-100...+300 mV
Low Range:	1LSB =	61nV ,	full range =	-1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.437 ± 0.1% (k=2)	403.891 ± 0.1% (k=2)	404.359 ± 0.1% (k=2)
Low Range	3.94121 ± 0.7% (k=2)	3.89867 ± 0.7% (k=2)	3.95408 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	127 ° ± 1 °

Appendix

1. DC Voltage Linearity

High Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	200000	200000.6	0.00
Channel X	+ Input	20000	20001.77	0.01
Channel X	- Input	20000	-19991.81	-0.04
Channel Y	+ Input	200000	199999.7	0.00
Channel Y	+ Input	20000	19999.20	0.00
Channel Y	- Input	20000	-19994.82	-0.03
Channel Z	+ Input	200000	200000.2	0.00
Channel Z	+ Input	20000	19996.22	-0.02
Channel Z	- Input	20000	-19996.74	-0.02

Low Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	2000	2000	0.00
Channel X	+ Input	200	200.05	0.03
Channel X	- Input	200	-200.88	0.44
Channel Y	+ Input	2000	1999.9	0.00
Channel Y	+ Input	200	199.73	-0.13
Channel Y	- Input	200	-200.53	0.27
Channel Z	+ Input	2000	2000.1	0.00
Channel Z	+ Input	200	199.25	-0.38
Channel Z	- Input	200	-201.42	0.71

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	13.15	12.30
	- 200	-12.61	-12.86
Channel Y	200	-7.43	-7.53
	- 200	6.30	6.52
Channel Z	200	-0.16	0.31
	- 200	-1.51	-1.48

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	1.90	-0.22
Channel Y	200	1.47	-	4.60
Channel Z	200	-1.40	-0.08	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15948	15814
Channel Y	15960	16073
Channel Z	16236	16172

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec
Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	0.03	-3.07	1.24	0.58
Channel Y	-0.66	-2.19	1.96	0.55
Channel Z	-0.91	-2.82	0.42	0.39

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2000	199.3
Channel Y	0.2000	200.4
Channel Z	0.2001	199.5

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

10. Common Mode Bit Generation (verified during pre test)

Typical values	Bit set to High at Common Mode Error (V_{DC})
Channel X, Y, Z	+1.25